


<b>Search Notes</b> 	<b>Application/Control No.</b> 10516562	<b>Applicant(s)/Patent Under Reexamination</b> BAHNEN, RUDOLF
	<b>Examiner</b> Ley, Francisco M	<b>Art Unit</b> 3709

SEARCHED			
Class	Subclass	Date	Examiner
318	721, 723	8/13/07	FML
417	247, 410.4, 410.1	8/9/07	FML
310	154.12	8/15/07	FML
318	808, 722	8/16/07	FML

SEARCH NOTES		
Search Notes	Date	Examiner
Examiner Bentsu Ro contacted for a search in class 318	8/9/07	FML
Examiner Michael Koczko contacted for a search in class 417	8/15/07	FML

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner